

**Search Notes**

Application/Control No.

10/692,318

Examiner

David L. Vanik

Applicant(s)/Patent under  
Reexamination

CHUN ET AL.

Art Unit

1615

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
424	70.9	2/16/2006	DV
424	70.1	2/16/2006	DV
424	70.11	2/16/2006	DV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	2/16/2006	DV
Inventor Search	2/16/2006	DV
PG Pub Interference Search-See Attached	2/17/2006	DV